# SN5433, SN54LS33, SN7433, SN74LS33 QUADRUPLE 2-INPUT POSITIVE NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

**SDLS101** 

DECEMBER 1983-REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic **DIPs**
- Dependable Texas Instruments Quality and Reliability

### description

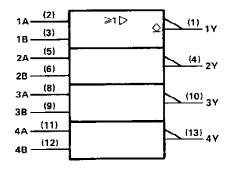
These devices contain four independent 2-input NOR buffer gates with open-collector outputs. Opencollector outputs require resistive pull-up to perform logically but can deliver higher VOH levels and are commonly used in wired-AND applications.

The SN5433 and SN54LS33 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN7433, and SN74LS33 are characterized for operation from 0°C to 70°C.

#### FUNCTION TABLE (each gate)

INP	UTS	OUTPUT
Α	В	Y
Н	х	L
×	H	Ĺ
L	L	H

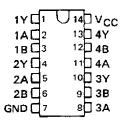
### logic symbol†



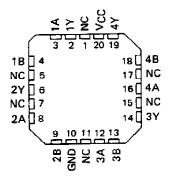
<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

SN5433, SN54LS33 . . . J OR W PACKAGE SN7433 . . . N PACKAGE SN74LS33 . . . D OR N PACKAGE (TOP VIEW)

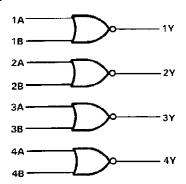


SN54LS33 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

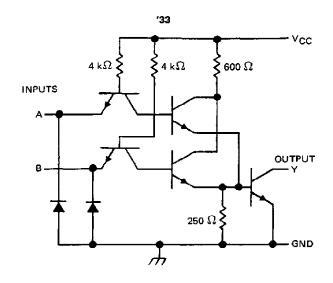
#### logic diagram

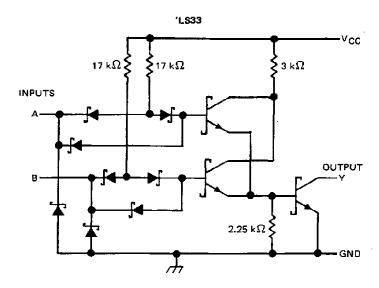


#### positive logic

 $Y = \overline{A + B} \text{ or } Y = \overline{A \cdot B}$ 

schematics (each gate)





Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)
Input voltage: '33 5.5 \
′L\$33 7 V
Off-state output voltage
Operating free-air temperature: SN54' –55°C to 125°C
SN74′
Storage temperature range
OTE 1: Voltage values are with respect to network ground terminal.

## SN5433, SN7433 QUADRUPLE 2-INPUT POSITIVE-NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

### recommended operating conditions

			SN5433			SN7433			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	V	
VIH	High-level input voltage	2			2			V	
VIL	Low-level input voltage			0.8			0.8	٧	
Vон	High-level output voltage			5.5			5.5		
loL	Low-level output current			48			48	mA	
TA	Operating free-air temperature	- 55		125	0		70	°C	

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS†	SN5433	-				
	TEST CONDITIONS	MIN TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA		-1.5			- 1.5	v
	$V_{CC} = MIN, V_{IL} = 0.8 \text{ V}, V_{OH} = 5.5 \text{ V}$					0.25	mA
ф	$V_{CC} = MIN, V_{IL} = 0.7 \text{ V}, V_{OH} = 5.5 \text{ V}$		0.25				nia.
VOL	V <sub>CC</sub> = MIN. V <sub>IH</sub> = 2 V, I <sub>OL</sub> = 16 mA	0.2	0.4		0.2	0.4	· V
tı	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V		. 1		·	1	mΑ
lн	$V_{CC} = MAX$ , $V_1 = 2.4 V$		40			40	μА
l)L	$V_{CC} = MAX$ , $V_1 = 0.4 V$		-1.6			- 1.6	mA
ІССН	VCC = MAX, VI = 0	3	6		3	6	mA
ICCL	V <sub>CC</sub> = MAX, See Note 2	9	16.5		9	16.5	mA

<sup>†</sup>For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

# switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25 \,^{\circ}\text{C}$ (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
tPLH	<del></del>		P. = 122 kg C. = 50 mE		10	15	ns
†PHL	A D	J	$R_L = 133 \text{ k}\Omega$ , $C_L = 50 \text{ pF}$		12	18	ns
t <sub>PLH</sub>	A or B	,	D 12210 C 150 mF		15	22	⊓\$
<sup>†</sup> PHL			$R_L = 133 \text{ k}\Omega$ , $C_L = 150 \text{ pF}$		16	24	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

 $<sup>^{\</sup>ddagger}$ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25 °C. NOTE 2: One input at 4.5 V, all others at 0 V.

## SN54LS33, SN74LS33 QUADRUPLE 2-INPUT POSITIVE-NOR BUFFERS WITH OPEN-COLLECTOR OUTPUTS

#### recommended operating conditions

	S	SN54L\$33			SN74LS33			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	V	
V <sub>IH</sub> High-level input voltage	2			2			V	
VIL Low-level input voltage			0,7			8.0	V	
VOH High-level output voltage			5.5			5.5	V	
IOL Low-level output current			12			24	mΑ	
TA Operating free-air temperature	- 55	_	125	0		70	°C	

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †			SN54LS33			SN74LS33			UNIT	
PARAMETER				MIN	TYP‡	MAX	MIN	TYP ‡	MAX	UNII	
VIK	VCC = MIN,	I <sub>I</sub> = - 18 mA					- 1.5			- 1.5	V
IOH	VCC = MIN,	V <sub>IH</sub> = 2 V,	VIL = MAX, VO	H = 5.5 V		· · · · ·	0.25	-		0.25	mΑ
) ( a .	V <sub>CC</sub> = MIN.	V <sub>IH</sub> = 2 V,	VIL = MAX, IOI	= 12 mA		0.25	0.4		0.25	0.4	I ∨ I
VOL	V <sub>CC</sub> = MIN,	VIL = MAX,	I <sub>OL</sub> = 24 mA						0.35	0.5	
11	VCC = MAX.	V <sub>1</sub> = 7 V					0.1			0.1	mΑ
Ιн	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 2.7 V					20			20	μА
IL	VCC = MAX,	V1 = 0.4 V					- 0,4	-		- 0.4	mA
Іссн	V <sub>CC</sub> = MAX.	V <sub>I</sub> = 0				1.8	3.6		1.8	3.6	mA
ICCL	V <sub>CC</sub> = MAX,	See Note 2				6.9	13.8		6.9	13.8	mA

<sup>†</sup>For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

### switching characteristics, VCC = 5 V, TA = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH .	A or B	V	$R_1 \approx 667  \Omega$ , $C_L = 45  pF$		20	32	ns
t₽HL	N 51 D	_ `			18	28	ns

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



 $<sup>^{\</sup>ddagger}$  All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25 °C. NOTE 2: One input at 4.5 V, all others at 0 V.

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